Search Notes

Application/Control No.

Applicant(s)/Patent under Reexamination

TAKESHITA, NOBUO

Art Unit

2653

10/021,000 Examiner

Kim-Kwok CHU

SEARCHED					
Class	Subclass	Date	Examiner		
369	44.7	6/27/2005	кс		
369	44.14	6/27/2005	кс		
369	44.11	6/27/2005	кс		
369	44.23	6/27/2005	КС		
369	44.25	6/27/2005	кс		
369	44.17	6/27/2005	КС		
369	44.37	6/27/2005	кс		
369	44.41	6/27/2005	кс		
369	44.33	6/27/2005	кс		
369	53.23	6/27/2005	кс		
369	53.41	6/27/2005	,KC		
369 .	90	6/27/2005	кс		
369	269	6/27/2005	кс		
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INTERFERENCE SEARCHED				
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